



## Product Change Notification: DSNO-02DXZ0965

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### Date:

10-Feb-2025

### Product Category:

AC/DC - Inductorless Offline Controllers

### Notification Subject:

CCB 7386 Final Notice: Qualification of MMT as new assembly site for SR10LG-G catalog part number (CPN) available in 8L SOIC (3.90mm) package.

### Affected CPNs:

**[DSNO-02DXZ0965\\_Affected\\_CPN\\_02102025.pdf](#)**

**[DSNO-02DXZ0965\\_Affected\\_CPN\\_02102025.csv](#)**

**PCN Status:** Final Notification

**PCN Type:** Manufacturing Change

**Microchip Parts Affected:** Please open one of the files found in the Affected CPNs section.

Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:** Qualification of MMT as new assembly site for SR10LG-G catalog part number (CPN) available in 8L SOIC (3.90mm) package.

### Pre and Post Summary Changes:

	Pre Change	Post Change
Assembly Site	UTAC Thai Limited (UTL-2) (NSEB)	Microchip Technology Thailand (MMT)
Wire Material	Au	Au
Die Attach Material	8200T	8390A

<b>Molding Compound Material</b>	G600	G600
<b>Lead-Frame Material</b>	A194	CDA194

Note: C194, A194 or CDA194 Lead frame material are the same, it is just a MCHP internal labelling difference.

**Impacts to Datasheet:** None

**Change Impact:** None

**Reason for Change:** To improve manufacturability by qualifying MMT as new assembly site.

**Change Implementation Status:** In Progress

**Estimated First Ship Date:** 31 March 2025 (date code: 2514)

**Note Below EFSD:** Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

**Timetable Summary:**

	<b>February 2025</b>					<b>March 2025</b>			
<b>Work Week</b>	05	06	07	08	09	10	11	12	13
<b>Qual Report Availability</b>		X							
<b>Final PCN Issue Date</b>		X							
<b>Estimated Implementation Date</b>									X

**Method to Identify Change:** Traceability Code

**Qualification Report:** Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:** February 10, 2025: Issued final notification.

**Note:** The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable product.

## **Attachments:**

**[PCN\\_DSNO-02DXZ0965\\_Qual\\_Report.pdf](#)**

Please contact your local **Microchip sales office** with questions or concerns regarding this notification.

## **Terms and Conditions:**

If you wish to receive Microchip PCNs via email please register for our PCN email service at our **PCN home page** select register then fill in the required fields. You will find instructions about registering for Microchips PCN email service in the **PCN FAQ** section.

If you wish to change your PCN profile, including opt out, please go to the **PCN home page** select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

Affected Catalog Part Numbers (CPN)

SR10LG-G



## **QUALIFICATION REPORT SUMMARY RELIABILITY LABORATORY**

**PCN #: DSNO-02DXZO965**

**Date  
June 19, 2021**

**Qualification of MMT as new assembly site for SR10LG-G catalog part number (CPN) available in 8L SOIC (3.90mm) package. This is a Q100 Grade 0 qualification and will qualify by similarity (QBS).**



## **MICROCHIP**

### **PACKAGE QUALIFICATION REPORT**

<b>Purpose</b>	Qualification of MMT as new assembly site for SR10LG-G catalog part number (CPN) available in 8L SOIC (3.90mm) package. This is a Q100 Grade 0 qualification and will qualify by similarity (QBS).
<b>CN</b>	ES350584
<b>QUAL ID</b>	R2001000 Rev. A
<b>MP CODE</b>	VA9027S7XA01
<b>Part No.</b>	MCP1722-3310H/S7X
<b>Bonding No.</b>	BDE-006378 Rev. 01
<b>CCB No.:</b>	4359 and 7386
<b><u>Package</u></b>	
<b>Type</b>	8L SOIC-EP
<b>Package size</b>	150 mils
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	95 x 130 mils
<b>Material</b>	A194
<b>Surface</b>	Double Ag Ring Plating
<b>Process</b>	Etched
<b>Lead Lock</b>	No
<b>Part Number</b>	10100847
<b>Treatment</b>	ME-2
<b><u>Material</u></b>	
<b>Epoxy</b>	8390A
<b>Wire</b>	Au wire
<b>Mold Compound</b>	G600V
<b>Plating Composition</b>	Matte Sn



## MICROCHIP PACKAGE QUALIFICATION REPORT

### Manufacturing Information

Assembly Lot No.	Wafer Lot No.	Date Code
MMT-213202607.000	TC08921225530.200	2045MSS
MMT-213302511.000	TC08921225530.200	20462UD
MMT-213302512.000	TC08921225530.200	20462UE

### Result

☒

Pass

☐

Fail

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8L SOIC-EP (150 mils) assembled by MMT pass reliability test per QCI-39000.

This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C reflow temperature per IPC/JEDEC J-STD-020E standard.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS	Result	Remarks
<b><u>Precondition Prior Perform Reliability Tests (At MSL Level 1)</u></b>	<b>Electrical Test:</b> +25°C and 150°C System: ETS-88	JESD22-A113	693(0)	693		Good Devices
	Bake 150°C, 24 hrs System: CHINEE	JIP/ IPC/JEDEC J-STD-020E		693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH			693		
	3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243			693		
	<b>Electrical Test:</b> +25°C and 150°C			0/693	Pass	
<b>Temp Cycle</b>	<b>Stress Condition:</b> -55°C to +150°C, 2000 Cycles System: TABAI ESPEC TSA-70H	JESD22-A104		231		Parts had been pre- conditioned at 260°C
	<b>Electrical Test:</b> +150°C System: ETS-88		231(0)	0/231	Pass	77 units / lot
	<b>Bond Strength:</b> Wire Pull (> 2.5 grams) Bond Shear (>15.00 grams)		15 (0) 15 (0)	0/15 0/15	Pass Pass	
<b>UNBIASED-HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22-A118		231		Parts had been pre- conditioned at 260°C
	<b>Electrical Test:</b> +25°C System: ETS-88		231(0)	0/231	Pass	77 units / lot
<b>HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> 3.3 Volts System: HAST 6000X	JESD22-A110		231		Parts had been pre- conditioned at 260°C
	<b>Electrical Test:</b> +25°C and 150°C System: ETS-88		231(0)	0/231	Pass	77 units / lot



## PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard / Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 1008 hrs System: SHEL LAB  <b>Electrical Test:</b> +25°C and 150°C System: ETS-88	JESD22-A103	45(0)	45  0/45	Pass	45 units
<b>Power Temperature Cycling</b>	<b>Stress Condition:</b> -40°C to +150°C, 1000 Cycles System: Votcsh  <b>Electrical Test:</b> +25°C and 150°C System: ETS-88	JESD22-A105	45(0)	45  0/45	Pass	45 units
<b>Physical Dimensions</b>	Physical Dimension, 10 units from 1 lot	JESD22-B100/B108	30(0) Units	0/30	Pass	30 units
<b>Bond Strength</b>	Wire Pull (> 4.00 grams)	Mil. Std. 883-2011	30 (0) Wires	0/30	Pass	
<b>Data Assembly</b>	Bond Shear (> 18.00 grams)	CDF-AEC-Q100-001	30 (0) bonds	0/30	Pass	